RENESAS

HIP2122, HIP2123

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DATASHEET

100V, 2A Peak, High Frequency Half-Bridge Drivers with Rising Edge Delay Timer

FN7670 Rev 0.00 December 23, 2011

The HIP2122 and HIP2123 are 100V, high frequency, halfbridge MOSFET driver ICs. They are based on the popular ISL2100A and ISL2101A half-bridge drivers. Like the ISL2100A, two logic inputs, LI and HI, control both bridge outputs, LO and HO. All logic inputs are V_{DD} tolerant.

These drivers have a programmable dead-time to insure break-before-make operation between the high-side and lowside drivers. The dead-time is adjustable up to 220ns. The internal logic does not prevent both outputs from turning on simultaneously if both inputs are high simultaneously for a time greater than the programmed delay.

A single PWM logic input controls both bridge outputs (HO, LO). An enable pin (EN), when low, drives both outputs to a low state. All logic inputs are V_{DD} tolerant and the HIP2122 has CMOS inputs with hysteresis for superior operation in noisy environments.

The HIP2122 has hysteretic inputs with thresholds that are proportional to V_{DD} . The HIP2123 has 3.3V logic/TTL compatible inputs.

Two package options are provided. The 10 lead 4x4 DFN package has standard pinouts. The 9 lead 4x4 DFN package omits pin 2 to comply with 100V conductor spacing per IPC-2221.

Features

- 9 Ld TDFN "B" Package Compliant with 100V Conductor Spacing Guidelines per IPC-2221
- Break-Before-Make Dead-Time Prevents Shoot-through and is adjustable up to 220ns
- Bootstrap Supply Max Voltage to 114VDC
- Wide Supply Voltage Range (8V to 14V)
- Supply Undervoltage Protection
- CMOS Compatible Input Thresholds with Hysteresis (HIP2122)
- 1.6 $\Omega/1 \Omega$ Typical Output Pull-up/Pull-down Resistance
- On-Chip 1Ω Bootstrap Diode

Applications

- Telecom Half-Bridge DC/DC Converters
- UPS and Inverters
- Motor Drives
- Class-D Amplifiers
- Forward Converter with Active Clamp

Related Literature

• [FN7668](http://www.intersil.com/data/fn/fn7668.pdf), HIP2120, HIP2121 "100V, 2A Peak, High Frequency Half-Bridge Drivers with Adjustable Dead Time Control and PWM Input"

Block Diagram

Pin Configurations

Pin Descriptions

Ordering Information

NOTES:

1. Add "-T*" suffix for tape and reel. Please refer to **[TB347](http://www.intersil.com/data/tb/tb347.pdf)** for details on reel specifications.

2. These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil PbHfree products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

3. "B" package option has alternate pin assignments for compliance with 100V Conductor Spacing Guidelines per IPC-2221. Note that Pin 2 is omitted for additional spacing.

4. For Moisture Sensitivity Level (MSL), please see device information page for [HIP2122,](http://www.intersil.com/products/deviceinfo.asp?pn=HIP2122#pricing) [HIP2123](http://www.intersil.com/products/deviceinfo.asp?pn=HIP2123#pricing). For more information on MSL please see tech brief [TB363](http://www.intersil.com/data/tb/tb363.pdf).

Table of Contents

Absolute Maximum Ratings Thermal Information

Maximum Recommended Operating Conditions

ESD Ratings

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTES:

- 5. The HIP2122 and HIP2123 are capable of derated operation at supply voltages exceeding 14V. Figure [20](#page-9-0) shows the high-side voltage derating curve for this mode of operation.
- 6. All voltages referenced to V_{SS} unless otherwise specified.
- 7. θ_{JA} is measured in free air with the component mounted on a high effective thermal conductivity test board with "direct attach" features. See Tech Brief [TB379](http://www.intersil.com/data/tb/tb379.pdf).
- 8. For θ_{JC} , the "case temp" location is the center of the exposed metal pad on the package underside.

Electrical Specifications $V_{DD} = V_{HB} = 12V$, $V_{SS} = V_{HS} = 0V$, $R_{DT} = 0_K$, PWM= 0V, No Load on LO or HO, Unless Otherwise Specified. Boldface limits apply over the operating temperature range, -40°C to +125°C.

Electrical Specifications $V_{DD} = V_{HB} = 12V$, $V_{SS} = V_{HS} = 0V$, $R_{DT} = 0_K$, PWM= 0V, No Load on LO or HO, Unless Otherwise Specified. Boldface limits apply over the operating temperature range, -40°C to +125°C.

NOTES:

9. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits are established by characterization and are not production tested.

10. Dead-Time is defined as the period of time between the LO falling and HO rising or between HO falling and LO rising when the LI and HI inputs transition simultaneously.

Timing Diagram

Typical Performance Curves

FIGURE 3. HIP2122 I_{DD} OPERATING CURRENT vs FREQUENCY FIGURE 4. HIP2123 I_{DD} OPERATING CURRENT vs FREQUENCY

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Typical Performance Curves (Continued)

FIGURE 11. HIP2122 PROPAGATION DELAYS vs TEMPERATURE FIGURE 12. HIP2123 PROPAGATION DELAYS vs TEMPERATURE

FIGURE 13. HIP2122 DELAY MATCHING vs TEMPERATURE FIGURE 14. HIP2123 DELAY MATCHING vs TEMPERATURE

1 .10-3 0.01 0.10 1.00

1 .10-4 1 .10-5 1 .10-6

FORWARD CURRENT (A)

FORWARD CURRENT (A)

IDD, IHB (µA)

(Au) aH (PD)

Typical Performance Curves (Continued)

FIGURE 15. PEAK PULL-UP CURRENT VS OUTPUT VOLTAGE FIGURE 16. PEAK PULL-DOWN CURRENT VS OUTPUT VOLTAGE

IDD

0 5 10 15 20

IHB

VDD, VHB (V)

0.3 0.4 0.5 0.6 0.7 0.8

FORWARD VOLTAGE (V)

FIGURE 17. HIP2122 QUIESCENT CURRENT VS VOLTAGE FIGURE 18. HIP2123 QUIESCENT CURRENT VS VOLTAGE

Functional Description

Functional Overview

The HIP2122/23 have independent control inputs, LI and HI, for each output; LO and HO. When LI is low, LO is low and likewise, when HI is low, HO is low. The output negative transitions occur with minimal (and fixed) propagation delays.

The positive transitions of each output are delayed by the programmed delay as set by RDT. With 80k, the delay is nominally 25ns. With 8k, the delay is nominally 220ns. Resistors values less than 8k and greater than 80k are not recommended. The delay time as a function of R_{DT} is approximately $t_{DT}(ns) = 2/R_{DT}$.

Delaying the rising edge but not the falling edge of each output is the technique that prevents shoot-thru. Please note that there is no logic that prevents both outputs from being on if both inputs are on simultaneously.

The enable pin, EN, when low, drives both outputs to a low state.

When the PWM input transitions, it is necessary to insure that both bridge FETS are not on at the same time to prevent shoot-through currents (break before make). The programmable dead time forces both outputs to be off before either of the bridge FETs is driven on. An 8kΩ resistor connected between R_{DT} and V_{SS} results in a nominal dead time of 250ns. An 80kΩ results with a minimum nominal dead time of 50ns. Resistors values less than 8k and greater than 80k are not recommended. Dead-time as a function of R_{DT} is nominally $t_{DT}(ns) = 2/R_{DT}$.

The high-side driver bias is established by the boot capacitor connected between HB and HS. The charge on the boot capacitor is provided by the internal boot diode that is connected to V_{DD} . The current path to charge the boot capacitor occurs when the low-side bridge FET is on. This charge current is limited in amplitude by the inherent resistance of the boot diode and by the drain-source voltage of the low-side FET. Assuming that the on time of the low-side FET is sufficiently long to fully charge the boot capacitor, the boot voltage will charge very close to V_{DD} (less the boot diode drop and the low-side FET on voltage).

When the HI input transitions high, the high-side bridge FET is driven on after the delay time. Because the HS node is connected to the source of the high-side FET, the HS node will rise almost to the level of the bridge voltage (less the conduction voltage across the bridge FET). Because the boot capacitor voltage is referenced to the source voltage of the high-side FET, the HB node is V_{DD} volts above the HS node and the boot diode is reversed biased. Because the high-side driver circuit is referenced to the HS node, the HO output is now approximately VHB + VBRIDGE above ground.

During the low to high transition of the HS node, the boot capacitor sources the necessary gate charge to fully enhance the high-side bridge FET gate. After the gate is fully charged, the boot capacitor no longer sources the charge to the gate but continues to provide bias current to the high-side driver. It is clear that the charge of the boot capacitor must be substantially larger than the required charge of the high-side FET and high-side driver otherwise the boot voltage will sag excessively. If the boot capacitor value is too small for the required maximum of on-time of the high-side FET, the high-side UV lockout may engage resulting with an unexpected operation.

Application Information

Selecting the Boot Capacitor Value

The boot capacitor value is chosen not only to supply the internal bias current of the high-side driver but also, and more significantly, to provide the gate charge of the driven FET without causing the boot voltage to sag excessively. In practice, the boot capacitor should have a total charge that is about 20 times the gate charge of the driven power FET for approximately a 5% drop in voltage after the charge has been transferred from the boot capacitor to the gate capacitance.

The following parameters are required to calculate the value of the boot capacitor for a specific amount of voltage droop. In this example, the values used are arbitrary. They should be changed to comply with the actual application.

The following equations calculate the total charge required for the Period. This equation assumes that all of the parameters are constant during the period duration. The error is insignificant if the ripple is small.

Q_c = Q_{gate80V} + Period x (I_{HB} + V_{HO}/R_{GS} + I_{gate_leak})

 $C_{boot} = Q_{c}/(Ripple * VDD)$

 $C_{\text{boot}} = 0.52 \mu F$

If the gate to source resistor is removed (R_{GS} is usually not needed or recommended), then:

 $C_{boot} = 0.33 \mu F$

Typical Application Circuit

Figure [23](#page-11-3) is an example of how the HIP2122/23 can be configured for a half bridge power supply application.

Depending on the application, the switching speed of the bridge FETs can be reduced by adding series connected resistors between the xHO outputs and the FET gates. Gate-Source resistors are recommended on the low Side FETs to prevent unexpected turn-on of the bridge should the bridge voltage be applied before VDD. Gate-source resistors on the high side FETs are not usually required if low-side gate-source resistors are used. If relatively small gate-source resistors are used on the high-side FETs, be aware that they will load the boot capacitor, which will then require a larger value for the boot capacitor.

Transients on HS Node

An important operating condition that is frequently overlooked by designers is the negative transient on the xHS pins that occurs when the high side bridge FET turns off. The Absolute Maximum transient allowed on the xHS pin is -6V but it is wise to minimize the amplitude to lower levels. This transient is the result of the parasitic inductance of the low-side drain-source conductor on the PCB. Even the parasitic inductance of the low-side FET contributes to this transient.

When the high-side bridge FET turns off (see Figure [22\)](#page-11-2), because of the inductive characteristics of the load, the current that was flowing in the high-side FET (blue) must rapidly commutate to flow through the low side FET (red). The amplitude of the negative transient impressed on the xHS node is (di/dt x L) where L is the total parasitic inductance of the low-side FET drainsource path and di/dt is the rate at which the high-side FET is turned off. With the increasing power levels of power supplies and motor, clamping this transient become more and more significant for the proper operation of the HIP2122/23.

FIGURE 22. PARASITIC INDUCTANCE CAUSES TRANSIENTS ON HS NODE

There are several ways of reducing the amplitude of this transient. If the bridge FETs are turned off more slowly to reduce di/dt, the amplitude will be reduced but at the expense of more switching losses in the FETs. Careful PCB design will also reduce the value of the parasitic inductance. However, these two solutions by themselves may not be sufficient. Figure [22](#page-11-2) illustrates a simple method for clamping the negative transient. A fast PN junction, 1A diode is connected between xHS and VSS as shown. It is important that this diode be placed as close as possible to the xHS and VSS pins to minimize the parasitic inductance of this current path. Because this clamping diode is essentially in parallel with the body diode of the low side FET, a small value resistor is necessary to limit current when the body diode of the low side bridge FET is conducting during the dead time.

Please note that a similar transient with a positive polarity occurs when the low-side FET turns off. This is less frequently a problem because xHS node is floating up toward the bridge bias voltage. The Absolute Max voltage rating for the xHS node does need to be observed when the positive transient occurs.

FIGURE 23. TYPICAL HALF BRIDGE APPLICATION

Power Dissipation

The dissipation of the HIP2122/23 is dominated by the gate charge required by the driven bridge FETs and the switching frequency. The internal bias and boot diode also contribute to the total dissipation but these losses are usually insignificant compared to the gate charge losses.

The calculation of the power dissipation of the HIP2122/23 is very simple.

Gate Power (for the HO and LO outputs):

 P_{gate} = 4 x Q_{gate} x Freq x VDD

where

 Q_{gate} is the charge of the driven bridge FET at VDD, and

Freq is the switching frequency.

Boot diode dissipation:

 $I_{\text{diode}_avg} = Q_{\text{gate}}$ x Freq

 $P_{\text{diode}} = I_{\text{diode_avg}} \times 0.6V$

where 0.6V is the diode conduction voltage

Bias current:

 $P_{bias} = I_{bias}$ x VDD

where I_{bias} is the internal bias current of the HIP2122/23 at the switching frequency

Total Power Dissipation:

 $P_{total} = P_{gate} + P_{diode} + P_{bias}$

Operating Temperatures:

 T_j = P_{total} x θ_{JA} + T_{amb}

where T_i is the junction temperature at the operating air temperature, T_{amb} , in the vicinity of the part.

T_j = P_{total} x θ_{JC} + T_{PCB}

where T_i is the junction temperature with the operating temperature of the PCB, T_{PCB} , measured where the EPAD is soldered.

PC Board Layout

The AC performance of the HIP2122/23 depends significantly on the design of the PC board. The following layout design guidelines are recommended to achieve optimum performance from the HIP2122/23:

- Understand well how power currents flow. The high amplitude di/dt currents of the bridge FETs will induce significant voltage transients on the associated traces.
- Keep power loops as short as possible by paralleling the source and return traces.
- Use planes where practical; they're usually more effective than parallel traces.
- Planes can also be non-grounded nodes.
- Avoid paralleling high di/dt traces with low level signal lines. High di/dt will induce currents in the low level signal lines.
- When practical, minimize impedances in low level signal circuits; the noise, magnetically induced on a 10k resistor, is 10x larger than the noise on a 1k resistor.
- Be aware of magnetic fields emanating from transformers and inductors. Core gaps in these structures are especially bad for emitting flux.
- If you must have traces close to magnetic devices, align the traces so that they are parallel to the flux lines.
- The use of low inductance components, such as chip resistors and chip capacitors is recommended.
- Use decoupling capacitors to reduce the influence of parasitic inductors. To be effective, these capacitors must also have the shortest possible lead lengths. If vias are used, connect several paralleled vias to reduce the inductance of the vias.
- It may be necessary to add resistance to dampen resonating parasitic circuits. The most likely circuit will be the HO and LO outputs. In PCB designs with long leads on the LI and HI inputs, it may also be necessary to add series resistors with the LI and HI inputs.
- Keep high dv/dt nodes away from low level circuits. Guard banding can be used to shunt away dv/dt injected currents from sensitive circuits. This is especially true for the PWM control circuits.
- Avoid having a signal ground plane under a high dv/dt circuit. This will inject high di/dt currents into the signal ground paths.
- Do power dissipation and voltage drop calculations of the power traces. Most PCB/CAD programs have built in tools for calculation of trace resistance.
- Large power components (Power FETs, Electrolytic capacitors, power resistors, etc.) will have internal parasitic inductance, which cannot be eliminated. This must be accounted for in the PCB layout and circuit design.
- If you simulate your circuits, consider including parasitic components.

EPAD Design Considerations

The thermal pad of the HIP2122/23 is electrically isolated. It's primary function is to provide heat sinking for the IC. It is recommended to tie the EPAD to V_{SC} (GND).

The following is an example of how to use vias to remove heat from the IC substrate.

FIGURE 24. TYPICAL PCB PATTERN FOR THERMAL VIAS

Depending on the amount of power dissipated by the HIP2122/23, it may be necessary, to connect the EPAD to one or more ground plane layers. A via array, within the area of the EPAD, will conduct heat from the EPAD to the GND plane on the bottom layer. If inner PCB layers are available, it is also be desirable to connect these additional layers with the plated-through vias.

The number of vias and the size of the GND planes required for adequate heatsinking is determined by the power dissipated by the HIP2122/23, the air flow, and the maximum temperature of the air around the IC.

It is important that the vias have a low thermal resistance for efficient heat transfer. Do not use "thermal relief" patterns to connect the vias.

Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to web to make sure you have the latest revision.

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For a complete listing of Applications, Related Documentation and Related Parts, please see the respective device information page on intersil.com: [HIP2122,](http://www.intersil.com/products/deviceinfo.asp?pn=hip2122) [HIP2123](http://www.intersil.com/products/deviceinfo.asp?pn=hip2123)

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Package Outline Drawing

L9.4x4

9 LEAD THIN DUAL FLAT NO-LEAD PLASTIC PACKAGE Rev 1, 1/10

0 . 2 REF

NOTES:

- Dimensions in () for Reference Only. 1. Dimensions are in millimeters.
- 2. Dimensioning and tolerancing conform to AMSE Y14.5m-1994.
- Unless otherwise specified, tolerance : Decimal ± 0.05 3.
- E-Pad is offset from center. $\sqrt{4}$.
- 5. Tiebar (if present) is a non-functional feature.
- located within the zone indicated. The pin #1 identifier may be The configuration of the pin #1 identifier is optional, but must be 6. either a mold or mark feature.

Package Outline Drawing

L10.4x4

10 LEAD THIN DUAL FLAT NO-LEAD PLASTIC PACKAGE Rev 1, 1/08

TOP VIEW

NOTES:

- Dimensions in () for Reference Only. 1. Dimensions are in millimeters.
- 2. Dimensioning and tolerancing conform to AMSE Y14.5m-1994.
- Unless otherwise specified, tolerance : Decimal ± 0.05 3.
- between 0.15mm and 0.30mm from the terminal tip. 4. Dimension b applies to the metallized terminal and is measured
- 5. Tiebar shown (if present) is a non-functional feature.
- located within the zone indicated. The pin #1 identifier may be The configuration of the pin #1 identifier is optional, but must be 6. either a mold or mark feature.

